

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Patent Application of

Megumi Takemoto et al.

Application No.: 10/645,595

Filed: August 22, 2003

For: A SEMICONDUCTOR DEVICE  
TEST PROBE (As Amended)

**MAIL STOP AMENDMENT**

Group Art Unit: 2829

Examiner: VINH P. NGUYEN

Confirmation No.: 9467

**AMENDMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In response to the Office Action mailed October 5, 2004, please amend the  
above-identified patent application as follows: